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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Active
Number of LABs/CLBs	-
Number of Logic Elements/Cells	-
Total RAM Bits	-
Number of I/O	101
Number of Gates	14000
Voltage - Supply	3V ~ 3.6V, 4.5V ~ 5.5V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 85°C (TA)
Package / Case	160-BQFP
Supplier Device Package	160-PQFP (28x28)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/a42mx09-2pqg160i

2.3 Ordering Information

The following figure shows ordering information. All the following tables show plastic and ceramic device resources, temperature and speed grade offerings.

Figure 1 • Ordering Information

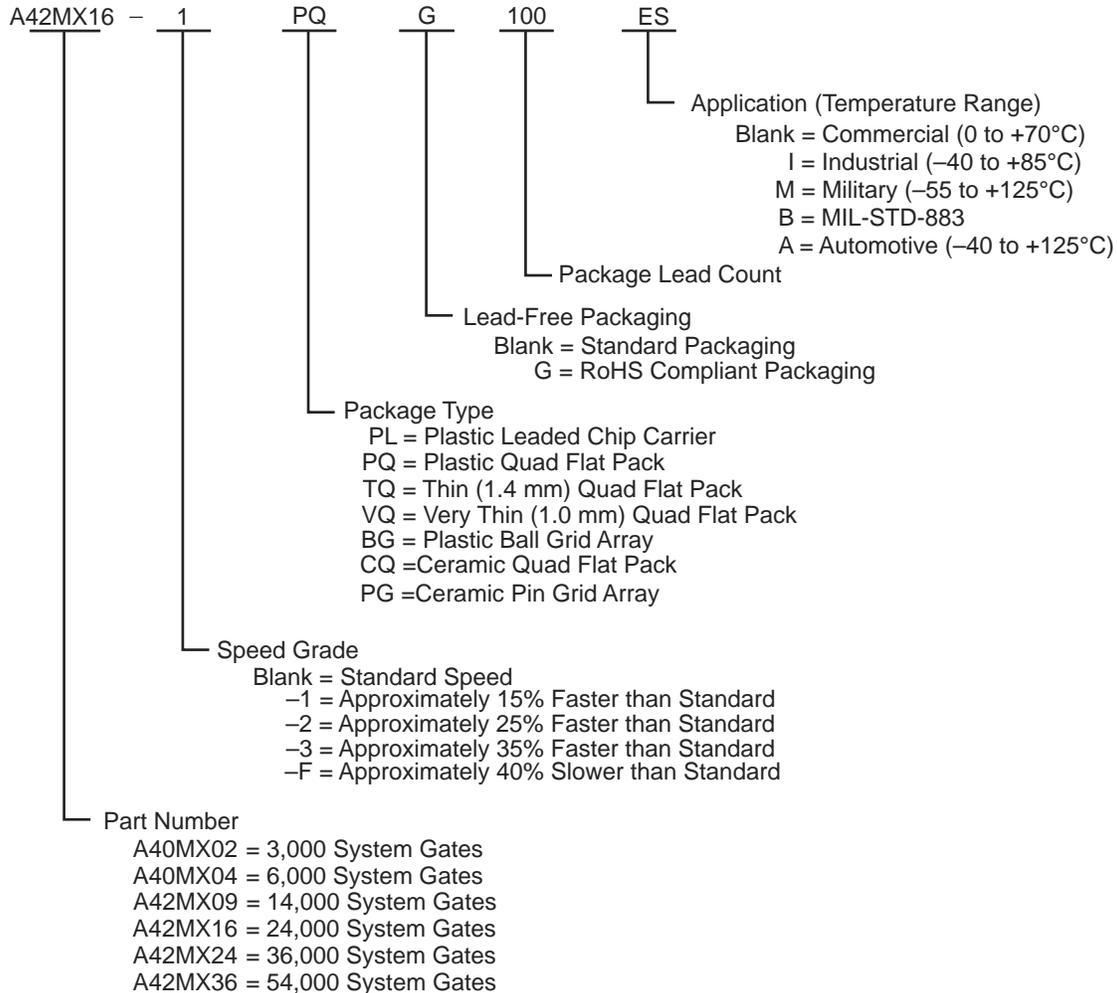
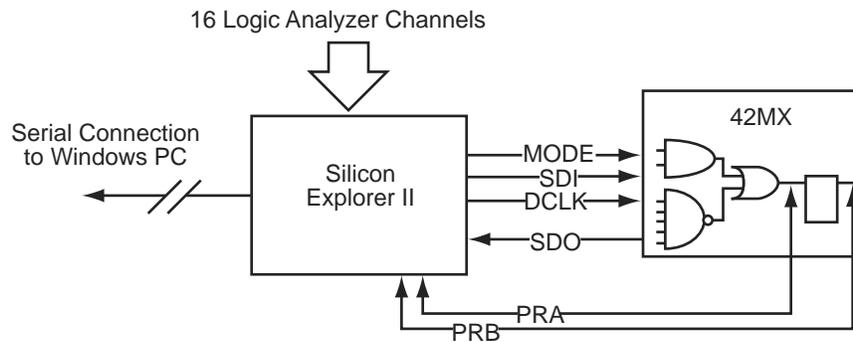


Figure 13 • Silicon Explorer II Setup with 42MX**Table 8 • Device Configuration Options for Probe Capability**

Security Fuse(s) Programmed	Mode	PRA, PRB ¹	SDI, SDO, DCLK ¹
No	LOW	User I/Os ²	User I/Os ²
No	HIGH	Probe Circuit Outputs	Probe Circuit Inputs
Yes	–	Probe Circuit Secured	Probe Circuit Secured

1. Avoid using SDI, SDO, DCLK, PRA and PRB pins as input or bidirectional ports. Since these pins are active during probing, input signals will not pass through these pins and may cause contention.
2. If no user signal is assigned to these pins, they will behave as unused I/Os in this mode. See the Pin Descriptions, page 83 for information on unused I/O pins

3.4.7 Design Consideration

It is recommended to use a series 70Ω termination resistor on every probe connector (SDI, SDO, MODE, DCLK, PRA and PRB). The 70 Ω series termination is used to prevent data transmission corruption during probing and reading back the checksum.

3.4.8 IEEE Standard 1149.1 Boundary Scan Test (BST) Circuitry

42MX24 and 42MX36 devices are compatible with IEEE Standard 1149.1 (informally known as Joint Testing Action Group Standard or JTAG), which defines a set of hardware architecture and mechanisms for cost-effective board-level testing. The basic MX boundary-scan logic circuit is composed of the TAP (test access port), TAP controller, test data registers and instruction register (Figure 14, page 18). This circuit supports all mandatory IEEE 1149.1 instructions (EXTEST, SAMPLE/PRELOAD and BYPASS) and some optional instructions. Table 9, page 18 describes the ports that control JTAG testing, while Table 10, page 18 describes the test instructions supported by these MX devices.

Each test section is accessed through the TAP, which has four associated pins: TCK (test clock input), TDI and TDO (test data input and output), and TMS (test mode selector).

The TAP controller is a four-bit state machine. The '1's and '0's represent the values that must be present at TMS at a rising edge of TCK for the given state transition to occur. IR and DR indicate that the instruction register or the data register is operating in that state.

The TAP controller receives two control inputs (TMS and TCK) and generates control and clock signals for the rest of the test logic architecture. On power-up, the TAP controller enters the Test-Logic-Reset state. To guarantee a reset of the controller from any of the possible states, TMS must remain high for five TCK cycles.

42MX24 and 42MX36 devices support three types of test data registers: bypass, device identification, and boundary scan. The bypass register is selected when no other register needs to be accessed in a device. This speeds up test data transfer to other devices in a test data path. The 32-bit device identification register is a shift register with four fields (lowest significant byte (LSB), ID number, part number and version). The boundary-scan register observes and controls the state of each I/O pin.

3.9.3 Output Drive Characteristics for 3.3 V PCI Signaling

Table 25 • DC Specification (3.3 V PCI Signaling)¹

Symbol	Parameter	Condition	PCI		MX		Units
			Min.	Max.	Min.	Max.	
VCCI	Supply Voltage for I/Os		3.0	3.6	3.0	3.6 ²	V
VIH	Input High Voltage		0.5	VCC + 0.5	0.5	VCCI + 0.3	V
VIL	Input Low Voltage		-0.5	0.8	-0.3	0.8	V
IIH	Input High Leakage Current	VIN = 2.7 V		70		10	μA
IIL	Input Leakage Current			-70		-10	μA
VOH	Output High Voltage	IOUT = -2 mA	0.9		3.3		V
VOL	Output Low Voltage	IOUT = 3 mA, 6 mA		0.1		0.1 VCCI	V
CIN	Input Pin Capacitance			10		10	pF
CCLK	CLK Pin Capacitance		5	12		10	pF
LPIN	Pin Inductance			20		< 8 nH ³	nH

1. PCI Local Bus Specification, Version 2.1, Section 4.2.2.1.

2. Maximum rating for VCCI -0.5 V to 7.0V.

3. Dependent upon the chosen package. PCI recommends QFP and BGA packaging to reduce pin inductance and capacitance.

Table 26 • AC Specifications for (3.3 V PCI Signaling)*

Symbol	Parameter	Condition	PCI		MX		Units
			Min.	Max.	Min.	Max.	
ICL	Low Clamp Current	-5 < VIN ≤ -1	-25 + (VIN + 1) / 0.015		-60	-10	mA
Slew (r)	Output Rise Slew Rate	0.2 V to 0.6 V load	1	4	1.8	2.8	V/ns
Slew (f)	Output Fall Slew Rate	0.6 V to 0.2 V load	1	4	2.8	4.0	V/ns

Note: *PCI Local Bus Specification, Version 2.1, Section 4.2.2.2.

Table 34 • A40MX02 Timing Characteristics (Nominal 5.0 V Operation) (continued)
(Worst-Case Commercial Conditions, VCC = 4.75 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
TTL Output Module Timing⁴											
t _{DLH}	Data-to-Pad HIGH	3.3		3.8		4.3		5.1		7.2	ns
t _{DHL}	Data-to-Pad LOW	4.0		4.6		5.2		6.1		8.6	ns
t _{ENZH}	Enable Pad Z to HIGH	3.7		4.3		4.9		5.8		8.0	ns
t _{ENZL}	Enable Pad Z to LOW	4.7		5.4		6.1		7.2		10.1	ns
t _{ENHZ}	Enable Pad HIGH to Z	7.9		9.1		10.4		12.2		17.1	ns
t _{ENLZ}	Enable Pad LOW to Z	5.9		6.8		7.7		9.0		12.6	ns
d _{TLH}	Delta LOW to HIGH	0.02		0.02		0.03		0.03		0.04	ns/pF
d _{THL}	Delta HIGH to LOW	0.03		0.03		0.03		0.04		0.06	ns/pF
CMOS Output Module Timing⁴											
t _{DLH}	Data-to-Pad HIGH	3.9		4.5		5.1		6.05		8.5	ns
t _{DHL}	Data-to-Pad LOW	3.4		3.9		4.4		5.2		7.3	ns
t _{ENZH}	Enable Pad Z to HIGH	3.4		3.9		4.4		5.2		7.3	ns
t _{ENZL}	Enable Pad Z to LOW	4.9		5.6		6.4		7.5		10.5	ns
t _{ENHZ}	Enable Pad HIGH to Z	7.9		9.1		10.4		12.2		17.0	ns
t _{ENLZ}	Enable Pad LOW to Z	5.9		6.8		7.7		9.0		12.6	ns
d _{TLH}	Delta LOW to HIGH	0.03		0.04		0.04		0.05		0.07	ns/pF
d _{THL}	Delta HIGH to LOW	0.02		0.02		0.03		0.03		0.04	ns/pF

1. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance
2. Set-up times assume fanout of 3. Further testing information can be obtained from the Timer utility
3. The hold time for the DFME1A macro may be greater than 0 ns. Use the Timer tool from the Designer software to check the hold time for this macro.
4. Delays based on 35pF loading

Table 35 • A40MX02 Timing Characteristics (Nominal 3.3 V Operation)
(Worst-Case Commercial Conditions, VCC = 3.0 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Logic Module Propagation Delays											
t _{PD1}	Single Module	1.7		2.0		2.3		2.7		3.7	ns
t _{PD2}	Dual-Module Macros	3.7		4.3		4.9		5.7		8.0	ns
t _{CO}	Sequential Clock-to-Q	1.7		2.0		2.3		2.7		3.7	ns
t _{GO}	Latch G-to-Q	1.7		2.0		2.3		2.7		3.7	ns
t _{RS}	Flip-Flop (Latch) Reset-to-Q	1.7		2.0		2.3		2.7		3.7	ns
Logic Module Predicted Routing Delays¹											

Table 36 • A40MX04 Timing Characteristics (Nominal 5.0 V Operation) (continued)(Worst-Case Commercial Conditions, VCC = 4.75 V, T_J = 70°C)

Parameter / Description		-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width	3.3		3.8		4.3		5.0		7.0		ns
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width	3.3		3.8		4.3		5.0		7.0		ns
t _A	Flip-Flop Clock Input Period	4.8		5.6		6.3		7.5		10.4		ns
f _{MAX}	Flip-Flop (Latch) Clock Frequency (FO = 128)		181		167		154		134		80	MHz
Input Module Propagation Delays												
t _{INYH}	Pad-to-Y HIGH		0.7		0.8		0.9		1.1		1.5	ns
t _{INYL}	Pad-to-Y LOW		0.6		0.7		0.8		1.0		1.3	ns
Input Module Predicted Routing Delays¹												
t _{IRD1}	FO = 1 Routing Delay		2.1		2.4		2.2		3.2		4.5	ns
t _{IRD2}	FO = 2 Routing Delay		2.6		3.0		3.4		4.0		5.6	ns
t _{IRD3}	FO = 3 Routing Delay		3.1		3.6		4.1		4.8		6.7	ns
t _{IRD4}	FO = 4 Routing Delay		3.6		4.2		4.8		5.6		7.8	ns
t _{IRD8}	FO = 8 Routing Delay		5.7		6.6		7.5		8.8		12.4	ns
Global Clock Network												
t _{CKH}	Input Low to HIGH	FO = 16	4.6		5.3		6.0		7.0		9.8	ns
		FO = 128	4.6		5.3		6.0		7.0		9.8	
t _{CKL}	Input High to LOW	FO = 16	4.8		5.6		6.3		7.4		10.4	ns
		FO = 128	4.8		5.6		6.3		7.4		10.4	
t _{PWH}	Minimum Pulse Width HIGH	FO = 16	2.2		2.6		2.9		3.4		4.8	ns
		FO = 128	2.4		2.7		3.1		3.6		5.1	
t _{PWL}	Minimum Pulse Width LOW	FO = 16	2.2		2.6		2.9		3.4		4.8	ns
		FO = 128	2.4		2.7		3.01		3.6		5.1	
t _{CKSW}	Maximum Skew	FO = 16	0.4		0.5		0.5		0.6		0.8	ns
		FO = 128	0.5		0.6		0.7		0.8		1.2	
t _P	Minimum Period	FO = 16	4.7		5.4		6.1		7.2		10.0	ns
		FO = 128	4.8		5.6		6.3		7.5		10.4	
f _{MAX}	Maximum Frequency	FO = 16	188		175		160		139		83	MHz
		FO = 128	181		168		154		134		80	
TTL Output Module Timing⁴												
t _{DLH}	Data-to-Pad HIGH		3.3		3.8		4.3		5.1		7.2	ns
t _{DHL}	Data-to-Pad LOW		4.0		4.6		5.2		6.1		8.6	ns
t _{ENZH}	Enable Pad Z to HIGH		3.7		4.3		4.9		5.8		8.0	ns
t _{ENZL}	Enable Pad Z to LOW		4.7		5.4		6.1		7.2		10.1	ns
t _{ENHZ}	Enable Pad HIGH to Z		7.9		9.1		10.4		12.2		17.1	ns

Table 36 • A40MX04 Timing Characteristics (Nominal 5.0 V Operation) (continued)(Worst-Case Commercial Conditions, VCC = 4.75 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
CMOS Output Module Timing¹											
t _{DLH}	Data-to-Pad HIGH	3.9	4.5	5.1	6.05	8.5	ns				
t _{DHL}	Data-to-Pad LOW	3.4	3.9	4.4	5.2	7.3	ns				
t _{ENZH}	Enable Pad Z to HIGH	3.4	3.9	4.4	5.2	7.3	ns				
t _{ENZL}	Enable Pad Z to LOW	4.9	5.6	6.4	7.5	10.5	ns				
t _{ENHZ}	Enable Pad HIGH to Z	7.9	9.1	10.4	12.2	17.0	ns				
t _{ENLZ}	Enable Pad LOW to Z	5.9	6.8	7.7	9.0	12.6	ns				
d _{TLH}	Delta LOW to HIGH	0.03	0.04	0.04	0.05	0.07	ns/pF				
d _{THL}	Delta HIGH to LOW	0.02	0.02	0.03	0.03	0.04	ns/pF				

1. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
2. Set-up times assume fanout of 3. Further testing information can be obtained from the Timer utility
3. The hold time for the DFME1A macro may be greater than 0 ns. Use the Timer utility from the Designer software to check the hold time for this macro.
4. Delays based on 35 pF loading

Table 37 • A40MX04 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCC = 3.0 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Logic Module Propagation Delays											
t _{PD1}	Single Module	1.7	2.0	2.3	2.7	3.7	ns				
t _{PD2}	Dual-Module Macros	3.7	4.3	4.9	5.7	8.0	ns				
t _{CO}	Sequential Clock-to-Q	1.7	2.0	2.3	2.7	3.7	ns				
t _{GO}	Latch G-to-Q	1.7	2.0	2.3	2.7	3.7	ns				
t _{RS}	Flip-Flop (Latch) Reset-to-Q	1.7	2.0	2.3	2.7	3.7	ns				
Logic Module Predicted Routing Delays¹											
t _{RD1}	FO = 1 Routing Delay	1.9	2.2	2.5	3.0	4.2	ns				
t _{RD2}	FO = 2 Routing Delay	2.7	3.1	3.5	4.1	5.7	ns				
t _{RD3}	FO = 3 Routing Delay	3.4	3.9	4.4	5.2	7.3	ns				
t _{RD4}	FO = 4 Routing Delay	4.1	4.8	5.4	6.3	8.9	ns				
t _{RD8}	FO = 8 Routing Delay	7.1	8.1	9.2	10.9	15.2	ns				
Logic Module Sequential Timing²											
t _{SUD}	Flip-Flop (Latch) Data Input Set-Up	4.3	5.0	5.6	6.6	9.2	ns				
t _{HD} ³	Flip-Flop (Latch) Data Input Hold	0.0	0.0	0.0	0.0	0.0	ns				
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up	4.3	5.0	5.6	6.6	9.2	ns				
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0	0.0	0.0	0.0	0.0	ns				

Table 37 • A40MX04 Timing Characteristics (Nominal 3.3 V Operation) (continued)(Worst-Case Commercial Conditions, VCC = 3.0 V, T_J = 70°C)

Parameter / Description		-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Input Module Predicted Routing Delays¹												
t _{IRD1}	FO = 1 Routing Delay		2.9		3.3		3.8		4.5		6.3	ns
t _{IRD2}	FO = 2 Routing Delay		3.6		4.2		4.8		5.6		7.8	ns
t _{IRD3}	FO = 3 Routing Delay		4.4		5.0		5.7		6.7		9.4	ns
t _{IRD4}	FO = 4 Routing Delay		5.1		5.9		6.7		7.8		11.0	ns
t _{IRD8}	FO = 8 Routing Delay		8.0		9.3		10.5		12.4		17.2	ns
Global Clock Network												
t _{CKH}	Input LOW to HIGH	FO = 16	6.4		7.4		8.4		9.9		13.8	ns
		FO = 128	6.4		7.4		8.4		9.9		13.8	
t _{CKL}	Input HIGH to LOW	FO = 16	6.8		7.8		8.9		10.4		14.6	ns
		FO = 128	6.8		7.8		8.9		10.4		14.6	
t _{PWH}	Minimum Pulse Width HIGH	FO = 16	3.1		3.6		4.1		4.8		6.7	ns
		FO = 128	3.3		3.8		4.3		5.1		7.1	
t _{PWL}	Minimum Pulse Width LOW	FO = 16	3.1		3.6		4.1		4.8		6.7	ns
		FO = 128	3.3		3.8		4.3		5.1		7.1	
t _{CKSW}	Maximum Skew	FO = 16	0.6		0.6		0.7		0.8		1.2	ns
		FO = 128	0.8		0.9		1.0		1.2		1.6	
t _P	Minimum Period	FO = 16	6.5		7.5		8.5		10.1		14.1	ns
		FO = 128	6.8		7.8		8.9		10.4		14.6	
f _{MAX}	Maximum Frequency	FO = 16	113		105		96		83		50	MHz
		FO = 128	109		101		92		80		48	
TTL Output Module Timing⁴												
t _{DLH}	Data-to-Pad HIGH		4.7		5.4		6.1		7.2		10.0	ns
t _{DHL}	Data-to-Pad LOW		5.6		6.4		7.3		8.6		12.0	ns
t _{ENZH}	Enable Pad Z to HIGH		5.2		6.0		6.9		8.1		11.3	ns
t _{ENZL}	Enable Pad Z to LOW		6.6		7.6		8.6		10.1		14.1	ns
t _{ENHZ}	Enable Pad HIGH to Z		11.1		12.8		14.5		17.1		23.9	ns
t _{ENLZ}	Enable Pad LOW to Z		8.2		9.5		10.7		12.6		17.7	ns
d _{TLH}	Delta LOW to HIGH		0.03		0.03		0.04		0.04		0.06	ns/pF
d _{THL}	Delta HIGH to LOW		0.04		0.04		0.05		0.06		0.08	ns/pF

Table 40 • A42MX16 Timing Characteristics (Nominal 5.0 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
CMOS Output Module Timing⁵											
t _{DLH}	Data-to-Pad HIGH	3.2	3.6	4.0	4.7	6.6	ns				
t _{DHL}	Data-to-Pad LOW	2.5	2.7	3.1	3.6	5.1	ns				
t _{ENZH}	Enable Pad Z to HIGH	2.7	3.0	3.4	4.0	5.6	ns				
t _{ENZL}	Enable Pad Z to LOW	3.0	3.3	3.8	4.4	6.2	ns				
t _{ENHZ}	Enable Pad HIGH to Z	5.4	6.0	6.8	8.0	11.2	ns				
t _{ENLZ}	Enable Pad LOW to Z	5.0	5.6	6.3	7.4	10.4	ns				
t _{GLH}	G-to-Pad HIGH	5.1	5.6	6.4	7.5	10.5	ns				
t _{GHL}	G-to-Pad LOW	5.1	5.6	6.4	7.5	10.5	ns				
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad), 64 Clock Loading	5.7	6.3	7.1	8.4	11.9	ns				
t _{ACO}	Array Clock-to-Out (Pad-to-Pad), 64 Clock Loading	8.0	8.9	10.1	11.9	16.7	ns				
d _{TLH}	Capacitive Loading, LOW to HIGH	0.03	0.03	0.03	0.04	0.06	ns/pF				

1. For dual-module macros, use t_{PD1} + t_{RD1} + t_{PDn}, t_{CO} + t_{RD1} + t_{PDn}, or t_{PD1} + t_{RD1} + t_{SUD}, point and position whichever is appropriate.
2. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
3. *Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.*
4. Set-up and hold timing parameters for the input buffer latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.
5. Delays based on 35 pF loading

Table 41 • A42MX16 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Logic Module Propagation Delays¹											
t _{PD1}	Single Module	1.9	2.1	2.4	2.8	4.0	ns				
t _{CO}	Sequential Clock-to-Q	2.0	2.2	2.5	3.0	4.2	ns				
t _{GO}	Latch G-to-Q	1.9	2.1	2.4	2.8	4.0	ns				
t _{RS}	Flip-Flop (Latch) Reset-to-Q	2.2	2.4	2.8	3.3	4.6	ns				
Logic Module Predicted Routing Delays²											
t _{RD1}	FO = 1 Routing Delay	1.1	1.2	1.4	1.6	2.3	ns				
t _{RD2}	FO = 2 Routing Delay	1.5	1.6	1.8	2.1	3.0	ns				
t _{RD3}	FO = 3 Routing Delay	1.8	2.0	2.3	2.7	3.8	ns				
t _{RD4}	FO = 4 Routing Delay	2.2	2.4	2.7	3.2	4.5	ns				
t _{RD8}	FO = 8 Routing Delay	3.6	4.0	4.5	5.3	7.5	ns				

Table 42 • A42MX24 Timing Characteristics (Nominal 5.0 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

Parameter / Description		-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Input Module Predicted Routing Delays²												
t _{IRD1}	FO = 1 Routing Delay		1.8		2.0		2.3		2.7		3.8	ns
t _{IRD2}	FO = 2 Routing Delay		2.1		2.3		2.6		3.1		4.3	ns
t _{IRD3}	FO = 3 Routing Delay		2.3		2.5		2.9		3.4		4.8	ns
t _{IRD4}	FO = 4 Routing Delay		2.5		2.8		3.2		3.7		5.2	ns
t _{IRD8}	FO = 8 Routing Delay		3.4		3.8		4.3		5.1		7.1	ns
Global Clock Network												
t _{CKH}	Input LOW to HIGH	FO = 32	2.6		2.9		3.3		3.9		5.4	ns
		FO = 486	2.9		3.2		3.6		4.3		5.9	ns
t _{CKL}	Input HIGH to LOW	FO = 32	3.7		4.1		4.6		5.4		7.6	ns
		FO = 486	4.3		4.7		5.4		6.3		8.8	ns
t _{PWH}	Minimum Pulse Width HIGH	FO = 32	2.2		2.4		2.7		3.2		4.5	ns
		FO = 486	2.4		2.6		3.0		3.5		4.9	ns
t _{PWL}	Minimum Pulse Width LOW	FO = 32	2.2		2.4		2.7		3.2		4.5	ns
		FO = 486	2.4		2.6		3.0		3.5		4.9	ns
t _{CKSW}	Maximum Skew	FO = 32	0.5		0.6		0.7		0.8		1.1	ns
		FO = 486	0.5		0.6		0.7		0.8		1.1	ns
t _{SUEXT}	Input Latch External Set-Up	FO = 32	0.0		0.0		0.0		0.0		0.0	ns
		FO = 486	0.0		0.0		0.0		0.0		0.0	ns
t _{HEXT}	Input Latch External Hold	FO = 32	2.8		3.1		3.5		4.1		5.7	ns
		FO = 486	3.3		3.7		4.2		4.9		6.9	ns
t _P	Minimum Period (1/f _{MAX})	FO = 32	4.7		5.2		5.7		6.5		10.9	ns
		FO = 486	5.1		5.7		6.2		7.1		11.9	ns

Table 44 • A42MX36 Timing Characteristics (Nominal 5.0 V Operation)(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
TTL Output Module Timing⁵ (Continued)											
t _{ENLZ}	Enable Pad LOW to Z		4.9	5.5	6.2	7.3	10.2	ns			
t _{GLH}	G-to-Pad HIGH		2.9	3.3	3.7	4.4	6.1	ns			
t _{GHL}	G-to-Pad LOW		2.9	3.3	3.7	4.4	6.1	ns			
t _{LSU}	I/O Latch Output Set-Up		0.5	0.5	0.6	0.7	1.0	ns			
t _{LH}	I/O Latch Output Hold		0.0	0.0	0.0	0.0	0.0	ns			
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		5.7	6.3	7.1	8.4	11.8	ns			
t _{ACO}	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O		7.8	8.6	9.8	11.5	16.1	ns			
d _{TLH}	Capacitive Loading, LOW to HIGH		0.07	0.08	0.09	0.10	0.14	ns/pF			
d _{THL}	Capacitive Loading, HIGH to LOW		0.07	0.08	0.09	0.10	0.14	ns/pF			

Table 44 • A42MX36 Timing Characteristics (Nominal 5.0 V Operation)(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
CMOS Output Module Timing⁵											
t _{DLH}	Data-to-Pad HIGH	3.5	3.9	4.5	5.2	7.3	ns				
t _{DHL}	Data-to-Pad LOW	2.5	2.7	3.1	3.6	5.1	ns				
t _{ENZH}	Enable Pad Z to HIGH	2.7	3.0	3.3	3.9	5.5	ns				
t _{ENZL}	Enable Pad Z to LOW	2.9	3.3	3.7	4.3	6.1	ns				
t _{ENHZ}	Enable Pad HIGH to Z	5.3	5.8	6.6	7.8	10.9	ns				
t _{ENLZ}	Enable Pad LOW to Z	4.9	5.5	6.2	7.3	10.2	ns				
t _{GLH}	G-to-Pad HIGH	5.0	5.6	6.3	7.5	10.4	ns				
t _{GHL}	G-to-Pad LOW	5.0	5.6	6.3	7.5	10.4	ns				
t _{LSU}	I/O Latch Set-Up	0.5	0.5	0.6	0.7	1.0	ns				
t _{LH}	I/O Latch Hold	0.0	0.0	0.0	0.0	0.0	ns				
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O	5.7	6.3	7.1	8.4	11.8	ns				
t _{ACO}	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O	7.8	8.6	9.8	11.5	16.1	ns				
d _{TLH}	Capacitive Loading, LOW to HIGH	0.07	0.08	0.09	0.10	0.14	ns/pF				
d _{THL}	Capacitive Loading, HIGH to LOW	0.07	0.08	0.09	0.10	0.14	ns/pF				

1. For dual-module macros, use t_{PD1} + t_{RD1} + t_{PDn}, t_{CO} + t_{RD1} + t_{PDn}, or t_{PD1} + t_{RD1} + t_{SUD}, whichever is appropriate.
2. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
3. Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.
4. Set-up and hold timing parameters for the Input Buffer Latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.
5. Delays based on 35 pF loading.

Table 45 • A42MX36 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Logic Module Combinatorial Functions¹											
t _{PD}	Internal Array Module Delay	1.9	2.1	2.3	2.7	3.8	ns				
t _{PDD}	Internal Decode Module Delay	2.2	2.5	2.8	3.3	4.7	ns				
Logic Module Predicted Routing Delays²											
t _{RD1}	FO = 1 Routing Delay	1.3	1.5	1.7	2.0	2.7	ns				
t _{RD2}	FO = 2 Routing Delay	1.8	2.0	2.3	2.7	3.7	ns				
t _{RD3}	FO = 3 Routing Delay	2.3	2.5	2.8	3.4	4.7	ns				
t _{RD4}	FO = 4 Routing Delay	2.8	3.1	3.5	4.1	5.7	ns				

Table 45 • A42MX36 Timing Characteristics (Nominal 3.3 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
t _{RD5}	FO = 8 Routing Delay		4.6	5.2	5.8	6.9	9.6	ns			
t _{RDD}	Decode-to-Output Routing Delay		0.5	0.5	0.6	0.7	1.0	ns			
Logic Module Sequential Timing^{3, 4}											
t _{CO}	Flip-Flop Clock-to-Output		1.8	2.0	2.3	2.7	3.7	ns			
t _{GO}	Latch Gate-to-Output		1.8	2.0	2.3	2.7	3.7	ns			
t _{SUD}	Flip-Flop (Latch) Set-Up Time		0.4	0.5	0.6	0.7	0.9	ns			
t _{HD}	Flip-Flop (Latch) Hold Time		0.0	0.0	0.0	0.0	0.0	ns			
t _{RO}	Flip-Flop (Latch) Reset-to-Output		2.2	2.4	2.7	3.2	4.5	ns			
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up		1.0	1.1	1.2	1.4	2.0	ns			
t _{HENA}	Flip-Flop (Latch) Enable Hold		0.0	0.0	0.0	0.0	0.0	ns			
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width		4.6	5.2	5.8	6.9	9.6	ns			
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width		6.1	6.8	7.7	9.0	12.6	ns			
Synchronous SRAM Operations											
t _{RC}	Read Cycle Time		9.5	10.5	11.9	14.0	19.6	ns			
t _{WC}	Write Cycle Time		9.5	10.5	11.9	14.0	19.6	ns			
t _{RCKHL}	Clock HIGH/LOW Time		4.8	5.3	6.0	7.0	9.8	ns			
t _{RCO}	Data Valid After Clock HIGH/LOW		4.8	5.3	6.0	7.0	9.8	ns			
t _{ADSU}	Address/Data Set-Up Time		2.3	2.5	2.8	3.4	4.8	ns			

4 Package Pin Assignments

The following figures and tables give the details of the package pin assignments.

Figure 38 • PL44

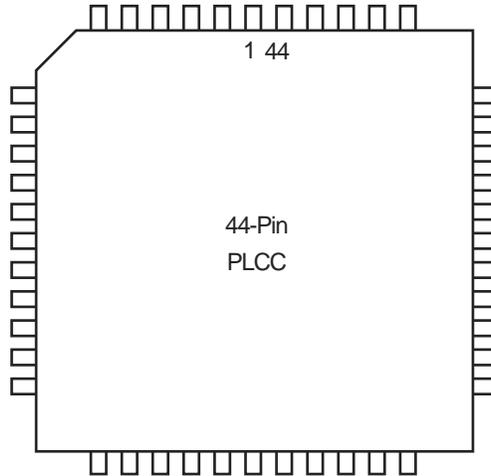


Table 47 • PL44

PL44		
Pin Number	A40MX02 Function	A40MX04 Function
1	I/O	I/O
2	I/O	I/O
3	VCC	VCC
4	I/O	I/O
5	I/O	I/O
6	I/O	I/O
7	I/O	I/O
8	I/O	I/O
9	I/O	I/O
10	GND	GND
11	I/O	I/O
12	I/O	I/O
13	I/O	I/O
14	VCC	VCC
15	I/O	I/O
16	VCC	VCC
17	I/O	I/O
18	I/O	I/O
19	I/O	I/O
20	I/O	I/O

Figure 42 • PQ144

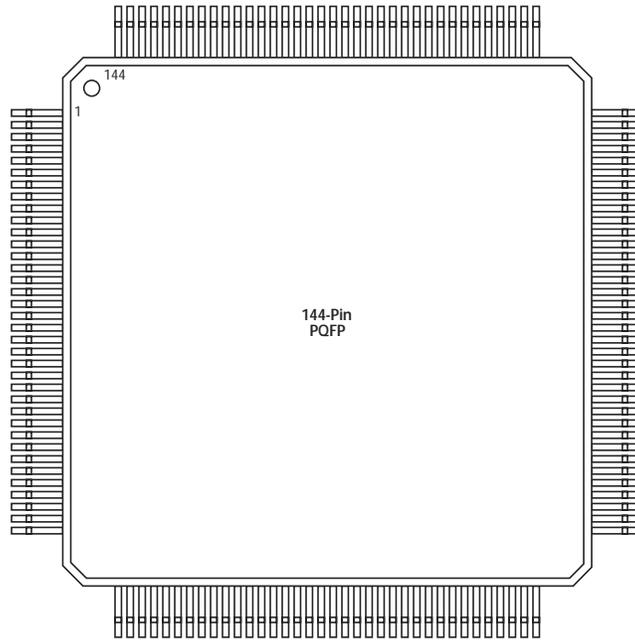


Table 51 • PQ144

PQ144	
Pin Number	A42MX09 Function
1	I/O
2	MODE
3	I/O
4	I/O
5	I/O

Table 51 • PQ144

PQ144	
Pin Number	A42MX09 Function
117	GNDI
118	NC
119	I/O
120	I/O
121	I/O
122	I/O
123	PROBA
124	I/O
125	CLKA
126	VCC
127	VCCI
128	NC
129	I/O
130	CLKB
131	I/O
132	PROBB
133	I/O
134	I/O
135	I/O
136	GND
137	GNDI
138	NC
139	I/O
140	I/O
141	I/O
142	I/O
143	I/O
144	DCLK

Table 54 • PQ240

PQ240	
Pin Number	A42MX36 Function
200	I/O
201	I/O
202	I/O
203	I/O
204	I/O
205	I/O
206	VCCA
207	I/O
208	I/O
209	VCCA
210	VCCI
211	I/O
212	I/O
213	I/O
214	I/O
215	I/O
216	I/O
217	I/O
218	I/O
219	VCCA
220	I/O
221	I/O
222	I/O
223	I/O
224	I/O
225	I/O
226	I/O
227	VCCI
228	I/O
229	I/O
230	I/O
231	I/O
232	I/O
233	I/O
234	I/O
235	I/O
236	I/O

Table 58 • CQ208

CQ208	
Pin Number	A42MX36 Function
111	I/O
112	I/O
113	I/O
114	I/O
115	I/O
116	I/O
117	I/O
118	I/O
119	I/O
120	I/O
121	I/O
122	I/O
123	I/O
124	I/O
125	I/O
126	GND
127	I/O
128	TCK, I/O
129	LP
130	VCCA
131	GND
132	VCCI
133	VCCA
134	I/O
135	I/O
136	VCCA
137	I/O
138	I/O
139	I/O
140	I/O
141	I/O
142	I/O
143	I/O
144	I/O
145	I/O
146	I/O
147	I/O

Table 60 • BG272

BG272	
Pin Number	A42MX36 Function
D20	I/O
E1	I/O
E2	I/O
E3	I/O
E4	VCCA
E17	VCCI
E18	I/O
E19	I/O
E20	I/O
F1	I/O
F2	I/O
F3	I/O
F4	VCCI
F17	I/O
F18	I/O
F19	I/O
F20	I/O
G1	I/O
G2	I/O
G3	I/O
G4	VCCI
G17	VCCI
G18	I/O
G19	I/O
G20	I/O
H1	I/O
H2	I/O
H3	I/O
H4	VCCA
H17	I/O
H18	I/O
H19	I/O
H20	I/O
J1	I/O
J2	I/O
J3	I/O
J4	VCCI

Table 60 • BG272

BG272	
Pin Number	A42MX36 Function
T19	I/O
T20	I/O
U1	I/O
U2	I/O
U3	I/O
U4	I/O
U5	VCCI
U6	WD, I/O
U7	I/O
U8	I/O
U9	WD, I/O
U10	VCCA
U11	VCCI
U12	I/O
U13	I/O
U14	QCLKB, I/O
U15	I/O
U16	VCCI
U17	I/O
U18	GND
U19	I/O
U20	I/O
V1	I/O
V2	I/O
V3	GND
V4	GND
V5	I/O
V6	I/O
V7	I/O
V8	WD, I/O
V9	I/O
V10	I/O
V11	I/O
V12	I/O
V13	WD, I/O
V14	I/O
V15	WD, I/O

Table 62 • CQ172

60	I/O
61	I/O
62	I/O
63	I/O
64	I/O
65	GND
66	VCC
67	I/O
68	I/O
69	I/O
70	I/O
71	I/O
72	I/O
73	I/O
74	I/O
75	GND
76	I/O
77	I/O
78	I/O
79	I/O
80	VCCI
81	I/O
82	I/O
83	I/O
84	I/O
85	SDO
86	I/O
87	I/O
88	I/O
89	I/O
90	I/O
91	I/O
92	I/O
93	I/O
94	I/O
95	I/O
96	I/O
97	I/O
98	GND